

Substitute for Form 1449/APTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/672,899
				Filing Date	September 26, 2003
				First Named Inventor	Rami Caspi et al.
				Group Art Unit	2686
				Examiner Name	Naghmeh Mehrpour
				Attorney Docket Number	2003P08215US
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Examiner Signature	/Naghmeh Mehrpour/	Date Considered	05/25/2007
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 Unique citation designation number. ²See attached Kinds of U.S. Patent Documents.